

July 2013

FQD10N20C / FQU10N20C

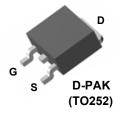
N-Channel QFET® MOSFET 200 V, 7.8 A, 360 m Ω

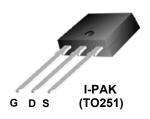
Description

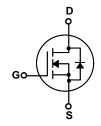
This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 7.8 A, 200 V, $R_{DS(on)}$ = 360 m Ω (Max.)@ V_{GS} = 10 V, I_D = 3.9 A
- Low Gate Charge (Typ. 20 nC)
- Low Crss (Typ. 40.5 pF)
- · 100% Avalanche Tested







Absolute Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		FQD10N20C / FQU10N20C	Unit
V _{DSS}	Drain-Source Voltage		200	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		7.8	А
			5.0	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	31.2	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	210	mJ
I _{AR}	Avalanche Current	(Note 1)	7.8	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		5.5	V/ns
P_D	Power Dissipation (T _C = 25°C)		50	W
	- Derate above 25°C		0.4	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	FQD10N20C / FQU10N20C	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	2.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient*	50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	110	°C/W

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Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
Off Cha	racteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		200			V
ΔBV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C			0.28		V/°(
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 200 V, V _{GS} = 0 V			-	10	μΑ
200		V _{DS} = 160 V, T _C = 125°C			-	100	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V				100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V				-100	nA
On Cha	racteristics						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 3.9 A			0.29	0.36	Ω
g _{FS}	Forward Transconductance	$V_{DS} = 40 \text{ V}, I_{D} = 3.9 \text{ A}$			5.6		S
C _{iss}	ic Characteristics Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz			395	510	pF
Coss	Output Capacitance				97	125	pF
C _{rss}	Reverse Transfer Capacitance				40.5	53	pF
Switchi	ng Characteristics						
t _{d(on)}	Turn-On Delay Time	V_{DD} = 100 V, I_{D} = 9.5 A, R_{G} = 25 Ω			11	30	ns
t _r	Turn-On Rise Time				92	190	ns
t _{d(off)}	Turn-Off Delay Time				70	150	ns
t _f	Turn-Off Fall Time		(Note 4)		72	160	ns
Qg	Total Gate Charge	V _{DS} = 160 V, I _D = 9.5 A,			20	26	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V (Note 4)			3.1		nC
Q _{gd}	Gate-Drain Charge				10.5		nC
Drain-S	ource Diode Characteristics a	nd Maximum Ratings					
I _S	Maximum Continuous Drain-Source Diode Forward Current					7.8	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				31.2	Α	
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 7.8 A				1.5	V
V SD	Dialif-Source Diode i diward voltage	VGS 0 V, IS 1.011				1.0	

 dI_F / dt = 100 A/ μ s

Q_{rr}

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 5.2mH, I_{AS} = 7.8A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C 3. $I_{SD} \le 9.5$ A, di/dt ≤ 300 A/ μ s, $V_{DD} \le BV_{DSS}$, Starting T_J = 25°C 4. Essentially independent of operating temperature

Reverse Recovery Charge

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μС

0.97

Typical Characteristics

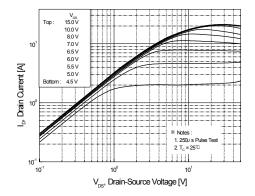


Figure 1. On-Region Characteristics

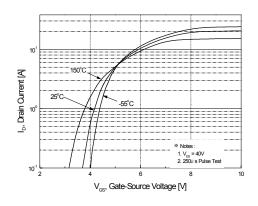


Figure 2. Transfer Characteristics

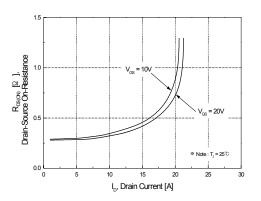


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

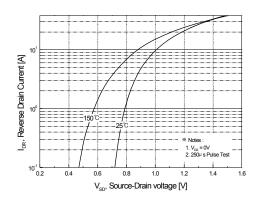


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

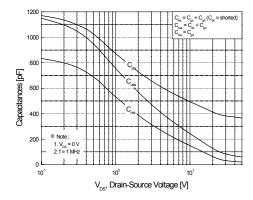


Figure 5. Capacitance Characteristics

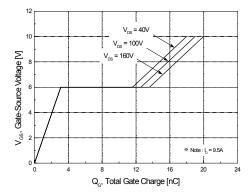
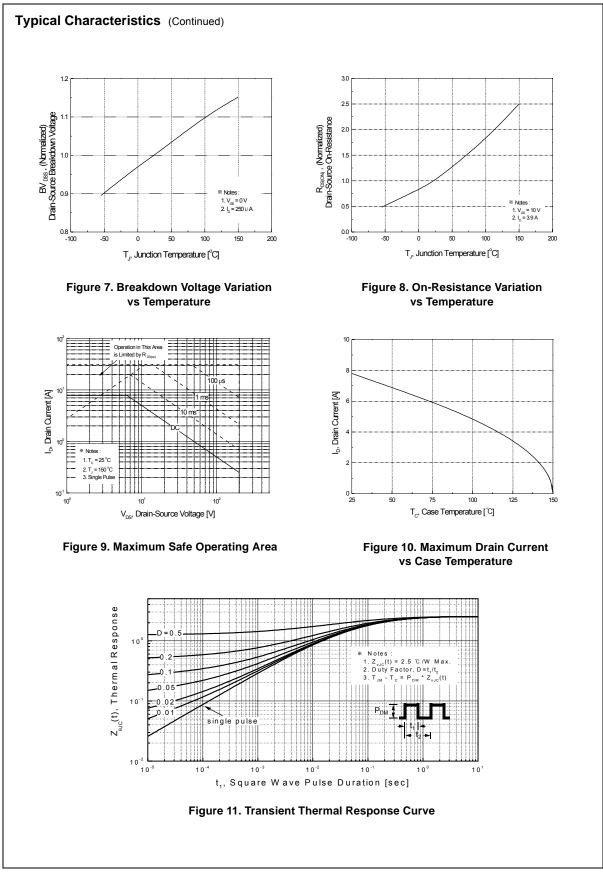
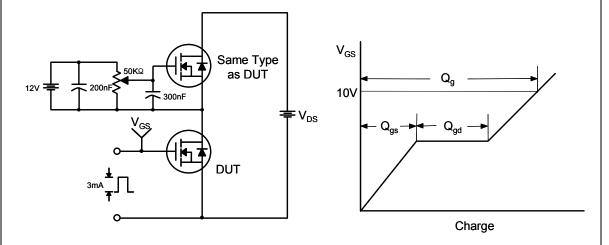


Figure 6. Gate Charge Characteristics

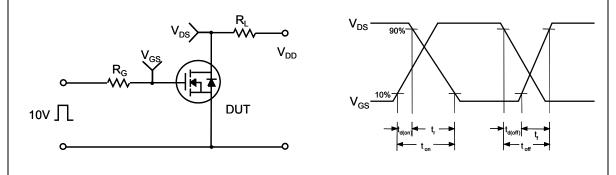


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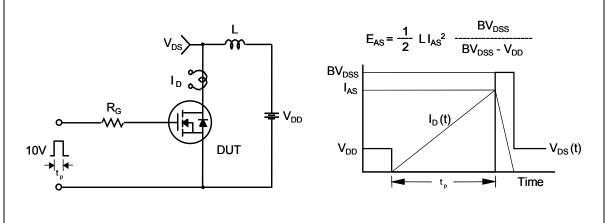
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



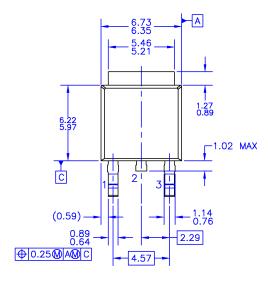
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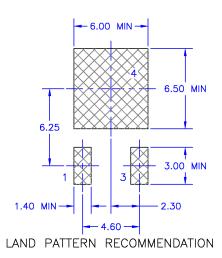
Peak Diode Recovery dv/dt Test Circuit & Waveforms DUT I_{SD} Driver Same Type as DUT V_{DD} $\prod V_{GS}$ \bullet dv/dt controlled by R_G • I_{SD} controlled by pulse period Gate Pulse Width V_{GS} Gate Pulse Period 10V (Driver) I_{FM} , Body Diode Forward Current I_{SD} di/dt (DUT) I_{RM} **Body Diode Reverse Current** V_{DS} (DUT) Body Diode Recovery dv/dt **Body Diode** Forward Voltage Drop

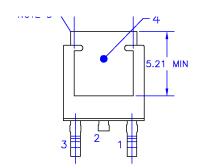
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Mechanical Dimensions

D-PAK







10.41 9.40 SEE DETAIL A △ 0.10 B 0.51 GAGE PLANE

1.78 1.40

(2.90)

DETAIL (ROTATED -90°) SCALE: 12X

NOTES: UNLESS OTHERWISE SPECIFIED

- INCLESS OTHERWISE SPECIFIED
 THIS PACKAGE CONFORMS TO JEDEC, TO-252,
 ISSUE C, VARIATION AA.
 ALL DIMENSIONS ARE IN MILLIMETERS.

- ALL DIMENSIONS ARE IN MILLIMETERS.
 DIMENSIONING AND TOLERANCING PER
 ASME Y14.5M-1994.
 HEAT SINK TOP EDGE COULD BE IN CHAMFERED
 CORNERS OR EDGE PROTRUSION.
 PRESENCE OF TRIMMED CENTER LEAD
 IS OPTIONAL.
- E)
- F)
- IS UPTIONAL.
 DIMENSIONS ARE EXCLUSSIVE OF BURSS,
 MOLD FLASH AND TIE BAR EXTRUSIONS.
 LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD
 T0220P1003X238-3N.
- DRAWING NUMBER AND REVISION: MKT-T0252A03REV8

TO-252 (DPAK) MOLDED, 3 LEAD, OPTION AA

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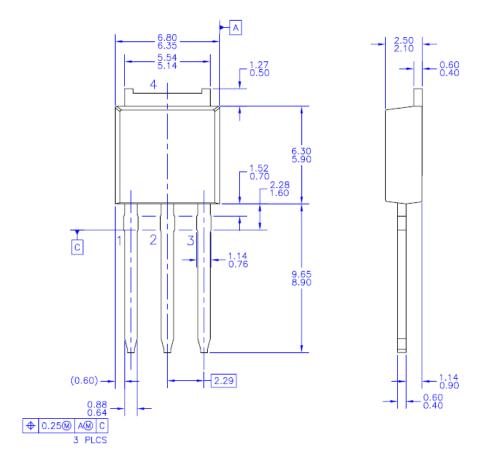
(1.54)

0.127 MAX

SEATING PLANE

Mechanical Dimensions

I-PAK





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Dimensions in Millimeters





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